Searcn Notes				

Application No.	Applicant(s)	
10/699,263	YOSHITOMI ET AL.	
Examiner	Art Unit	
Patrick Miller	2837	

	SEAR	CHED	
	JEAN		
Class	Subclass	Date	Examiner
318	254,439,6 96,138	9/6/2004	РМ

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
circulation; flyback; freewheeling; diode; absolute value/magnitude; Hall; integrated circuit/ASIC	9/6/2004	РМ